

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Topalov et al.

Docket No.: AOL0121

Serial No. : Unassigned

Art Unit: Unassigned

Filed: Herewith

Examiner: Unassigned

Title: A REVERSE MAPPING METHOD AND APPARATUS FOR FORM FILING

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents
Washington, DC 20231

Sir:

This Information Disclosure Statement is submitted:

- (X) under 37 CFR 1.97(b), or
(within three months of filing national application; or date of entry of international application; or before mailing date of first office action on the merits; whichever occurs last)
- () under 37 CFR 1.97(c) together with either a:
 - () Certification under 37 CFR 1.97(e), or
 - () a \$220.00 fee under 37 CFR 1.17(p), or
(After the CFR 1.97(b) time period, but before final action or notice of allowance, whichever occurs first)
- () under 37 CFR 1.97(d) together with a:
 - () Certification under 37 CFR 1.97(e), and
 - () a \$220.00 fee under 37 CFR 1.17(d)(2)(ii), and
 - () a \$130.00 petition fee set forth in 37 CFR 1.17(i)(1)
(Filed after final action or notice of allowance, whichever occurs first, but before payment of the issue fee)
- (X) The Commissioner is authorized to charge any additional fees or credit any overpayment to Deposit Account No. 07-1445 (Order No. AOL0121). A copy of this sheet is enclosed for accounting purposes.

(X) Applicant(s) submit herewith Form PTO 1449 -- Information Disclosure Citation together with copies of patents, publications or other information of which applicant(s) are aware, which applicant(s) believe(s) may be material to the examination of this application and for which there may be a duty to disclose in accordance with 37 CFR 1.25.

() A concise explanation of the relevance of foreign language patents, foreign language publications and other foreign language information listed on PTO Form 1449, as presently understood by the individual(s) designated in 37 CFR 156(c) most knowledgeable about the content is given on the attached sheet, or where a foreign language patent is cited in a search report or other action by a foreign patent office in a counterpart foreign application, an English language version of the search report or action which indicates the degree of relevance found by the foreign office is listed on form PTO 1449 and is enclosed herewith.

It is requested that the information disclosed herein be made of record in this application.

Respectfully Submitted,



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Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty. Docket No. AOL0121	Serial No.: Unassigned
	Applicant: Topalov et al. Filing Date: Herewith	Group: Unassigned

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A	6,151,581	11/21/00	Kraftson et al.	705	3	12/16/97
	B	6,199,079	3/6/01	Gupta et al.	707	507	3/20/98
	C	6,327,574	12/4/01	Kramer et al.	705	14	2/1/99
	D	6,400,996	6/4/02	Haffberg et al.	700	83	2/1/99
	E	6,490,601	12/3/02	Markus et al.	707	507	1/15/99
	F	6,519,571	2/11/03	Guheen et al.	705	14	5/27/99
	G	5,535,880	3/18/03	Musgrove et al.	707	10	5/9/00
	H	6,536,037	3/18/03	Guheen et al.	717	151	5/27/99

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	I	1 126 392	8/22/01	EPO	G06F	17/60	X	
	J	1 168 264	1/2/02	EPO	G07F	19/00	X	
	K	1 248 207	10/9/02	EPO	G06F	17/30	X	
	L	1 262 748	12/4/02	EPO	G01J	3/46	X	
	M	1 265 170	12/11/02	EPO	G06F	17/60	X	
	N	1 284 461	2/19/03	EPO	G06F	17/30	X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	O	<u>Paperwork Reduction By Means Of Data Mining</u> ; Pagnoni, A.; Parisi, S.; Attorrese, D.; Data Mining II. Second International Conference on Data Mining; 2000
	P	<u>LiveInfo: Adapting Web Experience By Customization And Annotation</u> ; P. Maglio, S. Farrell; IBM Almaden Research Center, San Jose, CA

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.